



ISA Analysis Division Program

May 05 - 09, 2019

Galveston Convention Center

The 64th Annual Symposium of the Analysis Division



"Returning to the Sea"

Date/Time	Session /Topic	Title / Developer	Location
SUNDAY May 05, 2019			
7:30 - 5:00	Registration	Symposium and Short Course Registration	Convention Center Lobby/Pre-Function Area
8:00 - 8:15	Track 1	Fundamentals of Process Analysis	Galleon I
		Introductions - Safety Moment, Introduction: Instructors and ISA AD chair, Class attendee introductions: Name, Company, Analyzer Role, Agenda Review & Class Protocol	
		<i>J.C. Arénes - Education Chair</i>	
8:15 - 9:15	Track 1	Fundamentals of Process Analysis	Galleon I
	Session 1	Fundamentals of Spectroscopy <i>Bob Bear - Instructor</i>	
9:15 - 10:15	Track 1	Fundamentals of Process Analysis	Galleon I
	Session 2	Fundamentals of Oxygen Analysis <i>Stuart Simmonds - Instructor</i>	
10:15 - 10:30	Track 1	Training Break	Convention Center Lobby/Pre-Function Area
10:30 - 11:30	Track 1	Fundamentals of Process Analysis	Galleon I
	Session 3	Fundamentals of Moisture & Dew Point Measurements <i>John Kerney - Instructor</i>	
11:30 - 12:00	Track 1	Training Lunch	Convention Center Lobby/Pre-Function Area
12:00 - 2:00	Track 1	Fundamentals of Process Analysis	Galleon I
	Session 4	Fundamentals of Gas Chromatography <i>Ulrich Gokeler - Instructor</i>	
2:00 - 2:15	Track 1	Training Break	Convention Center Lobby/Pre-Function Area
2:15 - 3:15	Track 1	Fundamentals of Process Analysis	Galleon I
	Session 5	Fundamentals of pH, Dissolved Oxygen and Conductivity Measurements <i>Tony Sandfoss - Instructor</i>	
3:15 - 4:15	Track 1	Fundamentals of Process Analysis	Galleon I
	Session 6	Concepts in Analyzer Integration <i>Michael Hoffman - Instructor</i>	
4:15 - 4:30	Track 1	Fundamentals of Process Analysis	Galleon I
		Conclusion - Q&A and Review of Fundamentals Training <i>J.C. Arénes - Education Chair</i>	

8:00 - 4:30	Track 1	Advanced Course: Increasing Sample System Reliability by Better Design	Spinnaker
	Session 7	This is a fast-moving course that explains many of the engineering procedures needed to design a gas or liquid sampling system for a process analyzer – all in about 7 hours of class time. The subjects to be covered include: • Sources of time delay • How to calculate transport lag for liquid and gas samples • How to evaluate a process tap location • The advantages of using a sampling probe – or not • Probe resonance calculations • The ideal fluid velocity in sample lines • Velocity and flow rate in complex sample lines • Turbulence and pressure loss in complex sample lines • How to determine friction factors • How to optimize the sample line sizes • Why partial pressure causes condensation • How to calculate the amount of condensation • Understanding the wet and dry basis of analysis • How to decide the temperature of heated lines or cabinets • How to solve the two big vaporizer problems • Why a phase diagram is a useful tool • The very strange consequence of allowing any condensation at all. Attendees will receive a course workbook that contains all of the presentation slides and detailed descriptions of the procedures used. The workbook also contains several class exercises that are completed during the course – most involving calculations. Since this is an advanced level class, the Instructor will assume you are aware of the basic objectives of a sampling system: to deliver a compatible, timely, and representative sample to a process analyzer in a reliable, cost-effective and safe manner.	
		<i>Phil Harris - Instructor</i>	

8:00 - 4:30	Track 1	Advanced Course: Multivariate Analysis for Inference and Analyzers	Harbor
	Session 8	This course examines a series of multivariate analytical techniques critical to the efficient operation of process monitoring and control. The data sources are from both process variable and analyzer sources. The course will demonstrate how to drink from a firehose; take the process variables and quickly turn them into a simplified data feed that can be interpreted for either optimizing process performance or developing a stronger understanding of the data. For the analyzers, the focus is on streamlining chemometric model construction to make the analyzers significantly more robust when put into routine practice. This class will also benefit those who perform both routine and irregular maintenance of chromatographic and spectroscopic instruments in both process and laboratory settings. A breakdown of the steps is provided to best process data for near infrared and Raman and maintain the calibration. Chromatographic applications will also be discussed and how the process leads to the simplification of calibration maintenance. The approaches described are independent of both hardware and software. By the end of the course, attendees will have been instructed on chemometrics best practices and the practical application of new techniques.	
		<i>Dr Brian Rohrbach - Instructor</i>	

4:15 - 5:05	Analysis Division	ISA SP-76 Business Meeting <i>Wes Carter - AD SP-76 Chair</i>	TBD
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5:15 - 6:15	Analysis Division	Analysis Division Business Meeting <i>AD Director Cynthia Cauthen (Chair) and AD Director-Elect Stuart Simmonds (Recording Secretary)</i>	TBD
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6:00 - 7:30 PM		Vendor Exhibit Tables <i>Hospitality and Welcoming to AD</i>	Analytical Technology Pavilion in Exhibit Hall A/B
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MONDAY MAY 06, 2019

6:00 - 8:00	Attendee	Attendee Breakfast	Convention Center Lobby/Pre-Function Area
7:30 - 5:00	Registration	Symposium Registration	Convention Center Lobby/Pre-Function Area
8:00 - 5:00	Spouses Program	Spouses Lounge - Tours, Shopping, Site-Seeing, & Recreation (open from 7:30 AM - 10 PM)	Check at Registration

Date/Time	Session	Paper Title - Author - Presenter	Location
8:00 - 8:15	General Session	Welcome Introduction - Ms Cindy Cauthen, (AD Director)	Galleon I-III
8:15 - 9:45	General Session	Session 1 - Fired Equipment Analyzers, Session Moderator - Wes Carter	Galleon I-III
	AD.19.01.01	TDLAS For Furnace Safety Dr. Peter Geiser NEO	
	AD.19.01.02	Multi-laser in-situ analyzer for real time control of deSOx and deNOx processes in a waste incinerator plant Pawel Kluczynski, Krzysztof Siembab, Mateusz Strazewski, Jakub Kaczmarek Airopic	
	AD.19.01.03	Combination of OFCEAS Spectroscopy and Low Pressure sampling for Real time measurement of H2S in varying hydrocarbon matrices David Chauvel Duraq Group - AP2E	

9:45 - 10:30	Break	Vendor Exhibit Tables	Analytical Technology Pavilion in Exhibit Hall A/B
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Date/Time	Session	Paper Title - Author - Presenter	Location
10:30 - 12:00	General Session	Session 2 - Miscellaneous Applications, Session Moderator - Stuart Simmonds	Galleon I-III
	AD.19.02.01	Comparison of Different VIV Abatement Techniques Arthi Appathurai, Paul Clews, and Xenia Vazquez CAE	
	AD.19.02.02	Not Sample Systems – Process Interfaces David Novak Siemens	
	AD.19.02.03	Deployment of Wireless Technology to Protect Environment and Save Energy in Haradh Gas Plant Najeeb Al-Hashim and Selvam Daniel Saudi Aramco	

12:00 - 1:15	Lunch	Vendor Exhibit Tables	Analytical Technology Pavilion in Exhibit Hall A/B
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Date/Time	Session	Paper Title - Author - Presenter	Location
1:15 - 2:45	General Session	Announcements - Information - Ms Cindy Cauthen (AD Director)	Galleon I-III
	General Session	Session 3 - Analyzers in Natural Gas Applications, Session Moderator - Al Kania	Galleon I-III
	AD.19.03.01	Plasmonic mercury analysis for natural gas processing Jay James Ph.D., Jeffrey Crosby Ph.D., and Donald Lucas Ph.D. Picoyune	
	AD.19.03.02	A Case Study of Fugitive Emissions at Producing Gas Wells Steve Smith, Les Howe, and Justin Smith Smith Analytical	
	AD.19.03.03	ON-LINE MEASUREMENTS OF CARBON DIOXIDE IN NATURAL GAS LIQUIDS RECOVERY PROCESS Airat Amerov Ametek	

2:45 - 3:30	Break	Vendor Exhibit Tables	Analytical Technology Pavilion in Exhibit Hall A/B
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Date/Time	Session	Paper Title - Author - Presenter	Location
3:30 - 5:00	General Session	Session 4 - New Developments, Session Moderator - Tim Kuiken	Galleon I-III
	AD.19.04.01	STATISTICAL PROCESS CONTROL AND MULTIVARIATE ANALYSIS Michael Roberto NWA Software	
	AD.19.04.02	Designing, Developing and Deploying Cybersecure Process Analyzers Peter Traynor Scheider Electric	
	AD.19.04.03	Opportunity Crudes present major Benefits and Risks Robert Sherman and Gary Rathwell Enterprise Consultants	

9:00 - 7:30		Vendor Exhibit Tables	Analytical Technology Pavilion in Exhibit Hall A/B
5:00 - 7:30 PM		Reception in Analytical Technology Pavilion in Exhibit Hall A	

TUESDAY MAY 07, 2019

6:00 - 8:00	Attendee	Attendee Breakfast	Convention Center Lobby/Pre-Function Area
7:30 - 5:00	Registration	Symposium Registration	Convention Center Lobby/Pre-Function Area
7:30 - 5:00	Visitors	VIP Visitors' Day	Analytical Technology Pavilion in Exhibit Hall A/B
8:00 - 5:00	Spouses Program	Spouses Lounge - Tours, Shopping, Site-Seeing, & Recreation (open from 7:30 AM - 10 PM)	Check at Registration

Date/Time	Session	Paper Title - Author - Presenter	Location
8:05 - 8:15	General Session	Welcome Introduction - Ms Cindy Cauthen, (AD Director)	Galleon I-III
8:15 - 9:45	General Session	Session 5 - Calibration Topics, Session Moderator - Tracy Dye Rethinking Calibration for Process Spectrometers	

	AD.19.05.01	Will Warkenton and Brian Rohrback Chevron and Infometrix	Galleon I-III
	AD.19.05.02	Review of process analyzer instrument standardization and calibration transfer for gasoline/diesel blending application Dr Hongqiang (Hank) Li and Dr James Brown Schneider	
	AD.19.05.03	EPA PROTOCOL GAS STANDARDS UPDATE Andy Shurtloff Airgas	
9:45 - 10:30		Break	Analytical Technology Pavilion in Exhibit Hall A/B
10:30 - 12:00		General Session	Session 6 - Management Systems and the Holmesian Fallacy, Session Moderator - Bac Vu
	AD.19.06.01	Data usage and quality in Digital Transformation Wouter Last Hint US	Galleon I-III
	AD.19.06.02	Analytical Reliability: A Maintenance Strategy Michael Hoffman Siemens	
	AD.19.06.03	h: a Holmesian Fallacy and the Mystery of Hydrofluoric Alkylation Catalyst Analysis Marcus Trynstad and Kevin Landreth Consultants	
12:00 - 1:15		Lunch	Analytical Technology Pavilion in Exhibit Hall A/B
1:15 - 2:45		General Session	Announcements - Information - Ms Cindy Cauthen (AD Director)
			Session 7 - Water Measurement Applications, Session Moderator - Alan Cowie
	AD.19.07.01	Monitoring Trace Levels of Water in Cracked Gas at the Outlet of Molecular Sieve Dryer Vessels Using Tunable Diode Laser Absorption Spectroscopy (TDLAS) Analyzers Gary Englehart, Dr. Sherry Liu and Luc Broekaert SpectraSensors	Galleon I-III
	AD.19.07.02	High Temperature Combustion -TOC (Total Organic Carbon) CT Starkweather Liquid Analytical Resources	
	AD.19.07.03	Tackling the calibration problem of water measurement in gases at low concentrations B. L. Livingstone and J.J. Gunnell Emerson	
2:45 - 3:30		Break	Analytical Technology Pavilion in Exhibit Hall A/B
3:30 - 4:45		General Session	Session 8 - Market Place and International, Session Moderator - Brian Rohrback
	AD.19.08.01	Global Update Mo Loch DMS	Galleon I-III
	AD.16.08.02		
	AD.19.08.02	PAI Partners Market Update Glenn Cudiamat, Stephen Walton, and Jim Tatera	
5:30 - 6:30		Banquet Social Hour	Analytical Technology Pavilion in Exhibit Hall A/B
6:30 - 8:00		Banquet	Featured NASA Speaker: Aaron Cannon - A Look at the Orion Multi-Purpose Crew Vehicle (MPCV) Program
9:00 AM - 5:00 PM		Vendor Exhibit Tables (closed during and after Banquet)	Analytical Technology Pavilion in Exhibit Hall A/B
WEDNESDAY MAY 08, 2019			
6:00 - 8:00		Attendee	Attendee Breakfast
7:30 - 5:00		Registration	Symposium Registration
8:00 - 5:00		Spouses Program	Spouses Lounge - Tours, Shopping, Site-Seeing, & Recreation (open from 7:30 AM - 10 PM)
			Convention Center Lobby/Pre-Function Area
			Convention Center Lobby/Pre-Function Area
			Check at Registration
Date/Time	Session	Paper Title - Author - Presenter	Location
8:05 - 8:15	General Session	Welcome Introduction - Ms Cindy Cauthen, (AD Director)	
8:15 - 9:45	General Session	Session 9 - Analyzer Applications [I], Session Moderator - JC Arenes	
	AD.19.09.01	How we turned an FTIR spectrometer into a universal concentration meter for the bulk and petrochemical industries Dan Wood, Jonathon Speed, Stephanie Wood. KEIT	Galleon I-III
	AD.19.09.02	How to add value on high viscosity products & residues using process viscometer P Burg Sofraser	
	AD.19.09.03	ISA Working Group - Vortex Shedding Probes By Invitation	TBD
9:45 - 10:30		Break	Analytical Technology Pavilion in Exhibit Hall A/B
10:30 - 12:00		General Session	Session 10 - Analyzer Applications [II], Session Moderator - Rod Spittler
	AD.19.10.01	Real-time Flare Control with Mass Spectrometers Jim Brenner, Haley Gabor, Chuck DeCarlo Extrel	Galleon I-III
	AD.19.10.02	FEED FORWARD ANALYSIS IN SULFUR RECOVERY UNITS Parisa Akhshi Ametek	
	AD.19.10.03	PAPER WITHDRAWN	
12:00 - 1:15		Lunch	Analytical Technology Pavilion in Exhibit Hall A/B
1:15 - 2:15		General Session	Announcements - Information - Ms Cindy Cauthen (AD Director)
			Session 11 - TDL Analyzer Developments, Session Moderator - Paul Cammarata
	AD.19.11.01	OPTICAL PATHLENGTH FOLDING VIA PRISM MECHANISM FOR USE WITH AN IN-SITU WAFER TUNABLE DIODE LASER SPECTROMETER Tyler Schertz, Ph.D., Jean-Nicolas Adami, Ph.D., Johanna Weigel, Ph.D. Mettler Toledo	Galleon I-III
	AD.19.11.02	Detection and Measurement of Broadband Molecules using arrays of QCLs G. Smirne Emerson	
	AD.19.11.03	PAPER WITHDRAWN	
2:15 - 3:00		Break	Analytical Technology Pavilion in Exhibit Hall A/B
3:00 - 4:00		General Session	Session 12 - Session Moderator
	AD.19.12.01	Panel Discussion on Analytical Measurements in the Natural Gas Industry	Galleon I-III

4:00 - 4:30	General Session	GTFK Award and POY Award - Moderator Paul Cammarata Closing Remarks- Ms Cindy Cauthen (AD Director)	
9:00 AM - 3:15 PM		Vendor Exhibit Tables	Analytical Technology Pavilion in Exhibit Hall A/B
THURSDAY MAY 09, 2019			
7:30 - 4:30	Registration	Vendor Training Registration	Convention Center Lobby/Pre-Function Area
12:00 - 1:00	Lunch	Training Lunch	Convention Center Lobby/Pre-Function Area
8am - Noon	COSA Xentaur	Combustion Calorimetry for the COSA9610 and 9700 Series Combustion Calorimetry for the COSA9610 and 9700 Series: This hands-on class will begin with brief overview of Combustion Calorimetry for the COSA9610 and 9700 series and move to the maintenance and troubleshooting application issues seen in the field for flare gas, fuel gas and custody transfer. Main areas to be covered for the maintenance will be the filtration pressure regulation, critical flow restrictors and combustion section components. Other areas covered will be the choosing of calibration gases, calibration procedures along with the electrical requirements and digital communication. <i>Dr. David Hailey</i>	Galleon I
8am - Noon	Ametek	888 Sulfur Recovery Tail Gas Analyzer As AMETEK's third generation sulfur recovery tail gas analyzer, the 888 brings all of the best elements of the iconic 880 NSL analyzer with a number of key improvements. This training will cover the differences between the 880 and 888 as well as sample system overview and practices. Relevant hands-on instruction will also be provided for basic maintenance, analyzer operation and software basics. <i>Duane Overholt</i>	Yacht
8am - 5pm	Siemens	Maxum Edition II (Gas Chromatograph) This will be a hands-on training class with live analyzers and NAUs networked. After a product update on the MAXUM GC platform, training will be given on upgrading a MAXUM GC to latest SysCon, color touch screen display and GCP software. A free 60-day demo CD of the Gas Chromatograph Portal (GCP) will be given to class attendees as part of hands-on GC workstation training. Attendees are encouraged to bring their laptops for assistance in installing the software. There will also be a review of using the MAXUM's advanced maintenance functions by reviewing the Statistic Monitoring (StatMon) and Analytical System Monitor (ASM) software package. Finally, we will have an open session to discuss specific topics of interest by the attendees. <i>Ulrich Gokeler</i>	Galleon II
8:00 - Noon	Yokogawa	TDL8000 Quick Startup, Troubleshooting and Maintenance Topics will include the following: Basic Theory of the TDL8 Understand Application Essentials Use the TruePeak Software Learn Calibration and Validation Learn to use Troubleshooting Diagnostics <i>Dale Cathey</i>	Harbor
1pm - 5pm	Yokogawa	GC8000 (Gas Chromatograph) Operation and Maintenance Class will start with brief overview of Chromatography basics to establish a common footing for all present. Primary component service procedures and recommendations will then be covered, for such items as Oven Valves, Liquid Sample Valves, and key parts. Programming and program modification will be next topic as done both on the unit and remotely accessed. This will cover standard chromatography, concurrent chromatography, and parallel chromatography as done on the GC8000 platform. The attendees will have the opportunity to actually perform these normal operations (change gate times, valve timing, standard area_cal factor etc.) and as well as the re-integration function on training units present. <i>Dale Cathey</i>	Harbor
8am - Noon	ABB	PGC5000 and the STAR Analyzer Management System This class provides an introductory operational overview of the PGC5000 process gas chromatograph and the STAR Analyzer Management System. Students will go through each operational menu of the highly versatile PGC5000 platform and review in general the analytical components and configurations that support basic GC applications and analyses. A brief overview of the new PGC5000 oven with integrated controller (PGC5000 IC) and optional wireless UI will also be provided. Finally, the STAR Analyzer Management System will be introduced including, STAR Client operations (statistical quality control, remote monitoring, trending, analyzer availability, maintenance logs and PGC1000 UI), STAR Server operations (network architecture, data storage and retrieval), how to remotely manage all files on all networked analyzers, and linking existing VistaNET networks and hardware with STAR including 3rd party OPC servers. A question and answer session touching on specific topics and questions coming from our students will conclude the hands-on training. <i>Tracy Dye</i>	Schooner
8am - Noon	Extrel	Mass Spec Gas Analyzers: Operation and Maintenance Industrial mass spectrometers are fast, full-composition gas analyzers used for flare gas compliance, trace contaminants in air, and fence line monitoring. They continuously quantify hydrocarbons, sulfurs, air components, VOCs, and other chemicals in complex, dynamic samples. This course will cover all the basics of operation, maintenance and application. Come see the mass spec, learn hands-on how to calibrate and run an analysis, and perform a full PM. <i>Haley Gabor</i>	Clipper
1pm - 4pm	Extrel	Real-time Flare Control: A Mass Spectrometer's Advantage As refineries continue to optimize their approach to RSR 63.670 compliance, new regulations for flare emissions are set to hit a broad range of industries over the next five years. The goal is to ensure the destruction of Hazardous Air Pollutants (HAPs) prior to release into the atmosphere, but drastic changes in vent gas composition make controlling that efficiency difficult. Getting the full composition of the vent gas quickly allows operations to apply corrections as soon as possible. Flare gas mass spectrometers measure hydrogen, hydrocarbons, carbon oxides, sulfurs, moisture and various volatile organics. In addition to reporting concentrations, the Net Heating Value (NHV) can also be reported to the control system in seconds. Examples of real-life flaring events will be discussed along with comparisons of analytical techniques during those events. <i>Jim Brenner</i>	Clipper
8am - Noon	Thermo Fisher	SOLA iQ Total Sulfur Analyzer This class will demonstrate the ease with which our SOLA iQ undergoes routine maintenance; our knowledgeable trainer will show you how with minimal experience the replacement components are swapped out and the analyzer brought back up and running with minimal downtime. We will also be on hand to answer any questions you may have about the operation and maintenance of the SOLA iQ and provide attendees with the differences between the SOLA II and the new SOLA iQ platform with it's simple but effective touch screen user interface and features. <i>Jim Keasbey</i>	Spinnaker